

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
259683US2PCTSERIAL NO.  
10/509,580

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Akira UMEDA

FILING DATE

September 29, 2004

GROUP

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>CDM</i>	AA	5 000 030	03/19/91	UMEDA, Akira et al.			
<i>1</i>	AB	5 952 554	09/14/99	UMEDA, Akira			
<i>CDM</i>	AC	6 286 359	09/11/01	UMEDA, Akira			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>CDM</i>	AO	5-273232	10/22/93	JP		NO
<i>CDM</i>	AP	3-109165	11/08/91	JP (with English abstract)		NO
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

*CDM*

Date Considered

*3/20/2006*

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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	AA						
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<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES                  NO		
<i>CDM</i>	AO	03-067175	03/22/91	JP (with English abstract & equivalent of US 5000030)		NO	
	AP	01-272903	10/31/89	JP (with English abstract)		NO	
	AQ	04-093653	03/26/92	JP (with English abstract)		NO	
<i>CDM</i>	AR	09-053912	02/25/97	JP (with English abstract & computer generated translation & equivalent of US 6286359)		NO	
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
<i>CDM</i>	AW	UMEDA, Akira et al. "Frequency Characteristics of Accelerometers Measured by Impact in Low Frequencies", The Japan Society of Mechanical Engineers, pages 477-482, with English abstract 1994					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>CDM</i>					Date Considered <b>3/20/2006</b>		
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